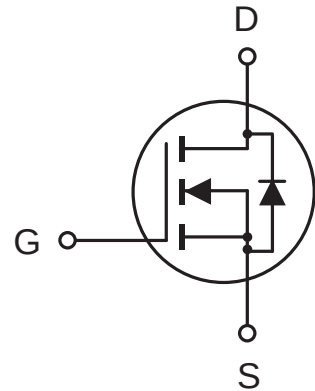
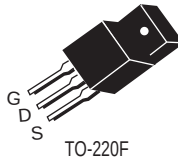


## N-Channel Logic Level Enhancement Mode Field Effect Transistor

### FEATURES

- 500V , 4.5A ,  $R_{DS(ON)}=1\Omega$  @ $V_{GS}=10V$ .
- Super high dense cell design for extremely low  $R_{DS(ON)}$ .
- High power and current handling capability.
- TO-220F full-pak for through hole



### ABSOLUTE MAXIMUM RATINGS ( $T_c=25^\circ\text{C}$ unless otherwise noted)

| Parameter                                                                             | Symbol         | Limit      | Unit                |
|---------------------------------------------------------------------------------------|----------------|------------|---------------------|
| Drain-Source Voltage                                                                  | $V_{DS}$       | 500        | V                   |
| Gate-Source Voltage                                                                   | $V_{GS}$       | $\pm 30$   | V                   |
| Drain Current-Continuous<br>-Pulsed                                                   | $I_D$          | 4.5        | A                   |
|                                                                                       | $I_{DM}$       | 13.5       | A                   |
| Drain-Source Diode Forward Current                                                    | $I_S$          | 4.5        | A                   |
| Maximum Power Dissipation @ $T_c=25^\circ\text{C}$<br>Derate above $25^\circ\text{C}$ | $P_D$          | 45         | W                   |
|                                                                                       |                | 0.36       | W/ $^\circ\text{C}$ |
| Operating and Storage Temperature Range                                               | $T_J, T_{STG}$ | -65 to 150 | $^\circ\text{C}$    |

### THERMAL CHARACTERISTICS

|                                         |                 |     |                    |
|-----------------------------------------|-----------------|-----|--------------------|
| Thermal Resistance, Junction-to-Case    | $R_{\theta JC}$ | 2.8 | $^\circ\text{C/W}$ |
| Thermal Resistance, Junction-to-Ambient | $R_{\theta JA}$ | 65  | $^\circ\text{C/W}$ |

## ELECTRICAL CHARACTERISTICS (Tc=25°C unless otherwise noted)

| Parameter                                        | Symbol              | Condition                                                                                        | Min | Typ  | Max  | Unit |
|--------------------------------------------------|---------------------|--------------------------------------------------------------------------------------------------|-----|------|------|------|
| <b>DRAIN-SOURCE AVALANCHE RATING<sup>a</sup></b> |                     |                                                                                                  |     |      |      |      |
| Single Pulse Drain-Source Avalanche Energy       | E <sub>AS</sub>     | V <sub>DD</sub> =50V, L=24mH<br>R <sub>G</sub> =25Ω                                              |     | 500  |      | mJ   |
| Maximum Drain-Source Avalanche Current           | I <sub>AS</sub>     |                                                                                                  |     | 6    |      | A    |
| <b>OFF CHARACTERISTICS</b>                       |                     |                                                                                                  |     |      |      |      |
| Drain-Source Breakdown Voltage                   | BV <sub>DSS</sub>   | V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA                                                     | 500 |      |      | V    |
| Zero Gate Voltage Drain Current                  | I <sub>DSS</sub>    | V <sub>DS</sub> = 500V, V <sub>GS</sub> = 0V                                                     |     |      | 25   | μA   |
| Gate-Body Leakage                                | I <sub>GSS</sub>    | V <sub>GS</sub> = ±30V, V <sub>DS</sub> = 0V                                                     |     |      | ±100 | nA   |
| <b>ON CHARACTERISTICS<sup>a</sup></b>            |                     |                                                                                                  |     |      |      |      |
| Gate Threshold Voltage                           | V <sub>GS(th)</sub> | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA                                       | 2   |      | 4    | V    |
| Drain-Source On-State Resistance                 | R <sub>DS(ON)</sub> | V <sub>GS</sub> =10V, I <sub>D</sub> = 4A                                                        |     | 0.85 | 1.0  | Ω    |
| On-State Drain Current                           | I <sub>D(ON)</sub>  | V <sub>GS</sub> = 10V, V <sub>DS</sub> = 10V                                                     | 6   |      |      | A    |
| Forward Transconductance                         | g <sub>FS</sub>     | V <sub>DS</sub> = 50V, I <sub>D</sub> = 4A                                                       |     | 4    |      | S    |
| <b>SWITCHING CHARACTERISTICS<sup>b</sup></b>     |                     |                                                                                                  |     |      |      |      |
| Turn-On Delay Time                               | t <sub>D(ON)</sub>  | V <sub>DD</sub> =250V,<br>I <sub>D</sub> = 6A,<br>V <sub>GS</sub> = 10V<br>R <sub>GEN</sub> =18Ω |     | 23   | 45   | ns   |
| Rise Time                                        | t <sub>r</sub>      |                                                                                                  |     | 35   | 70   | ns   |
| Turn-Off Delay Time                              | t <sub>D(OFF)</sub> |                                                                                                  |     | 162  | 240  | ns   |
| Fall Time                                        | t <sub>f</sub>      |                                                                                                  |     | 44   | 90   | ns   |
| Total Gate Charge                                | Q <sub>g</sub>      | V <sub>DS</sub> =400V, I <sub>D</sub> = 6A,<br>V <sub>GS</sub> =10V                              |     | 54   | 65   | nC   |
| Gate-Source Charge                               | Q <sub>gs</sub>     |                                                                                                  |     | 9    |      | nC   |
| Gate-Drain Charge                                | Q <sub>gd</sub>     |                                                                                                  |     | 27   |      | nC   |

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## ELECTRICAL CHARACTERISTICS (Tc=25°C unless otherwise noted)

| Parameter                                       | Symbol           | Condition                                               | Min | Typ | Max | Unit |
|-------------------------------------------------|------------------|---------------------------------------------------------|-----|-----|-----|------|
| DYNAMIC CHARACTERISTICS <sup>b</sup>            |                  |                                                         |     |     |     |      |
| Input Capacitance                               | C <sub>ISS</sub> | V <sub>DS</sub> =25V, V <sub>GS</sub> = 0V<br>f =1.0MHz |     | 823 |     | pF   |
| Output Capacitance                              | C <sub>OSS</sub> |                                                         |     | 110 |     | pF   |
| Reverse Transfer Capacitance                    | C <sub>RSS</sub> |                                                         |     | 64  |     | pF   |
| DRAIN-SOURCE DIODE CHARACTERISTICS <sup>a</sup> |                  |                                                         |     |     |     |      |
| Diode Forward Voltage                           | V <sub>SD</sub>  | V <sub>GS</sub> = 0V, I <sub>S</sub> =6A                |     |     | 1.5 | V    |

Notes

- a.Pulse Test:Pulse Width≤300 μ s, Duty Cycle ≤ 2%.
- b.Guaranteed by design, not subject to production testing.

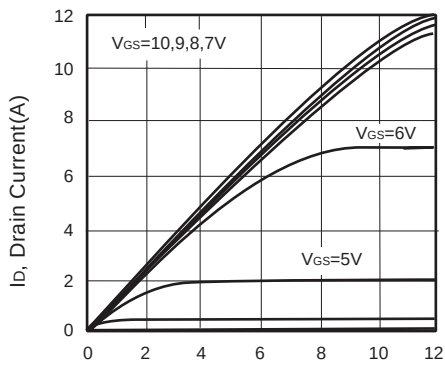


Figure 1. Output Characteristics

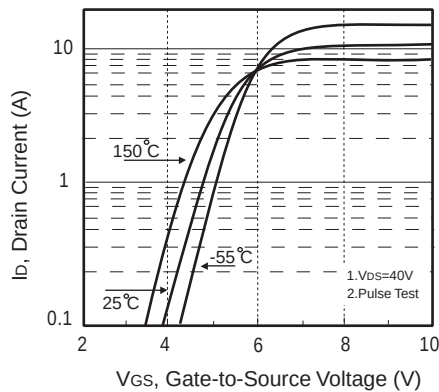
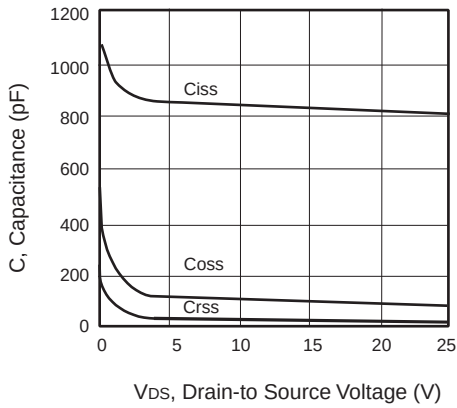
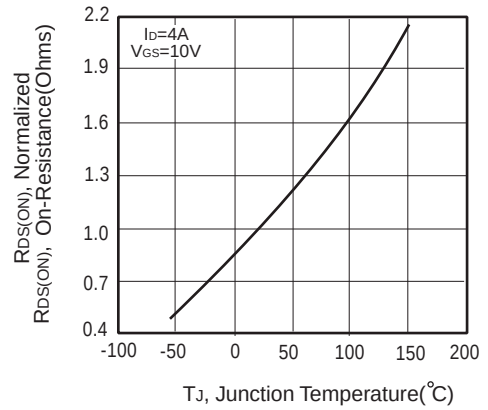


Figure 2. Transfer Characteristics

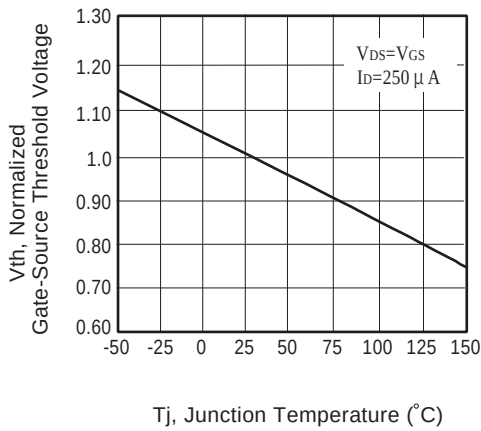
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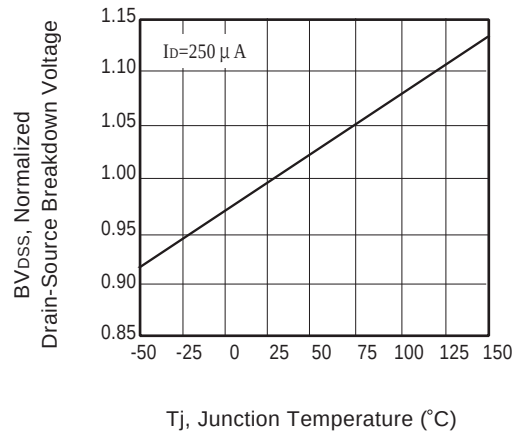
**Figure 3. Capacitance**



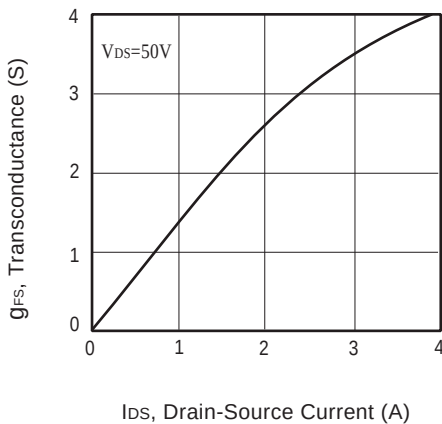
**Figure 4. On-Resistance Variation with Temperature**



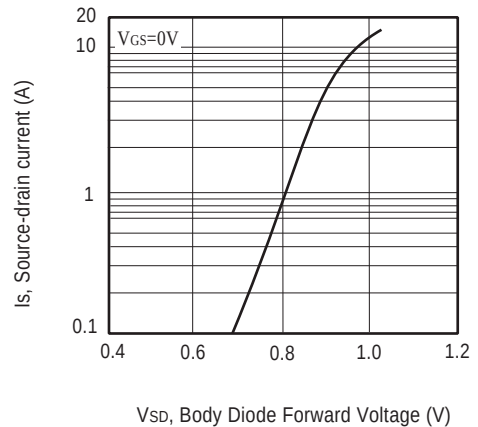
**Figure 5. Gate Threshold Variation with Temperature**



**Figure 6. Breakdown Voltage Variation with Temperature**

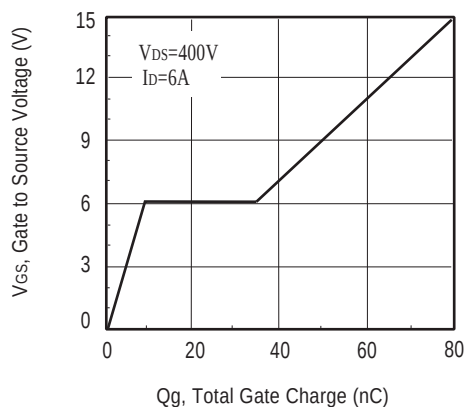


**Figure 7. Transconductance Variation with Drain Current**

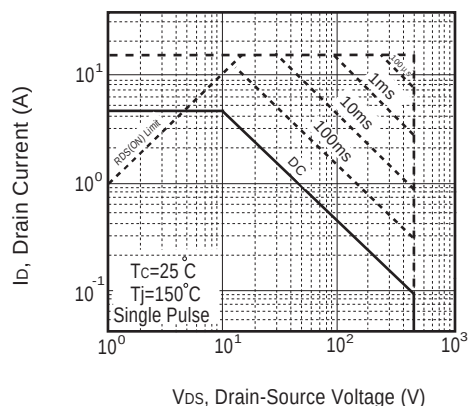


**Figure 8. Body Diode Forward Voltage Variation with Source Current**

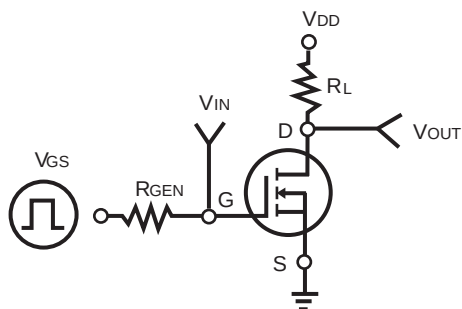
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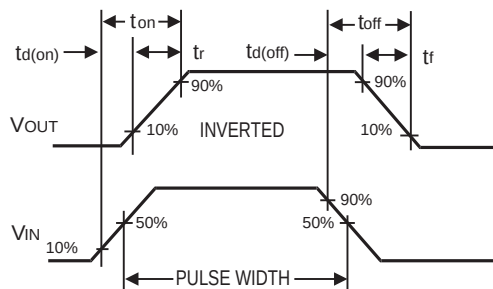
**Figure 9. Gate Charge**



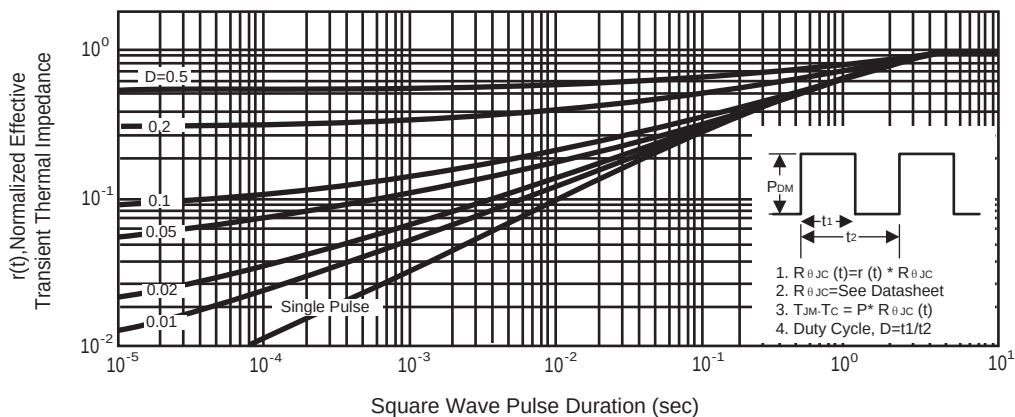
**Figure 10. Maximum Safe Operating Area**



**Figure 11. Switching Test Circuit**



**Figure 12. Switching Waveforms**



**Figure 13. Normalized Thermal Transient Impedance Curve**